



## 7580D (文件编号: S&CIC1692)

## N-Channel Trench Power MOSFET

### General Description

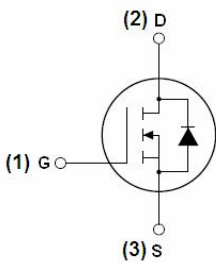
The 7580D is N-channel MOS Field Effect Transistor designed for high current switching applications. Rugged EAS capability and ultra low  $R_{DS(ON)}$  is suitable for PWM, load switching especially for E-Bike controller applications.

### Features

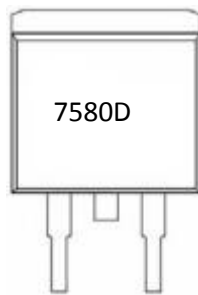
- $V_{DS}=75V$ ;  $I_D=86A@ V_{GS}=10V$ ;  
 $R_{DS(ON)}<8.5m\Omega @ V_{GS}=10V$
- Special Designed for E-Bike Controller Application
- Ultra Low On-Resistance
- High UIS and UIS 100% Test

### Application

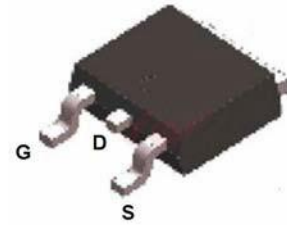
- 64V E-Bike Controller Applications
- Hard Switched and High Frequency Circuits
- Uninterruptible Power Supply



Schematic diagram



Marking and pin assignment



TO-263top view

### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
7580D	7580D	TO-263	-	-	-

Table 1. Absolute Maximum Ratings (TA=25°C)

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-Source Voltage ( $V_{GS}=0V$ )	75	V
$V_{GS}$	Gate-Source Voltage ( $V_{DS}=0V$ )	$\pm 20$	V
$I_{D(DC)}$	Drain Current (DC) at $T_c=25^\circ C$	86	A
$I_{D(DC)}$	Drain Current (DC) at $T_c=100^\circ C$	60.4	A
$I_{DM(pulse)}$	Drain Current-Continuous@ Current-Pulsed (Note 1)	368	A
dv/dt	Peak Diode Recovery Voltage	7.3	V/ns
$P_D$	Maximum Power Dissipation( $T_c=25^\circ C$ )	147	W
	Derating Factor	0.93	W/°C
EAS	Single Pulse Avalanche Energy (Note 2)	625	mJ
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 To 175	°C

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.EAS condition: $T_J=25^\circ C, V_{DD}=40V, V_{BG\beta}=10V, R_G=25\Omega$



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Table 2. Thermal Characteristic

Symbol	Parameter	Value	Max	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	---	1.02	°C/W

Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)

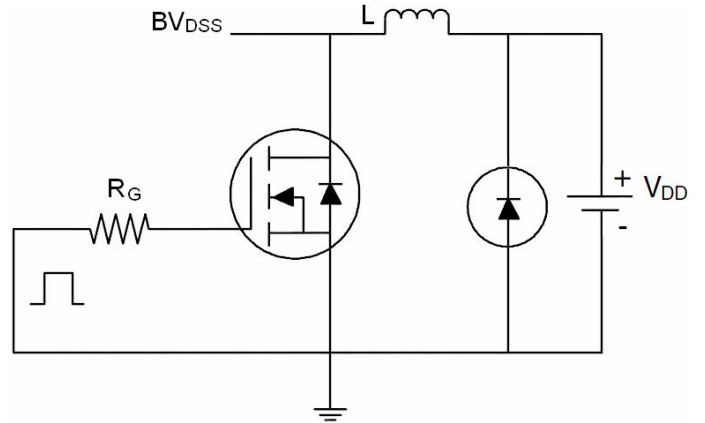
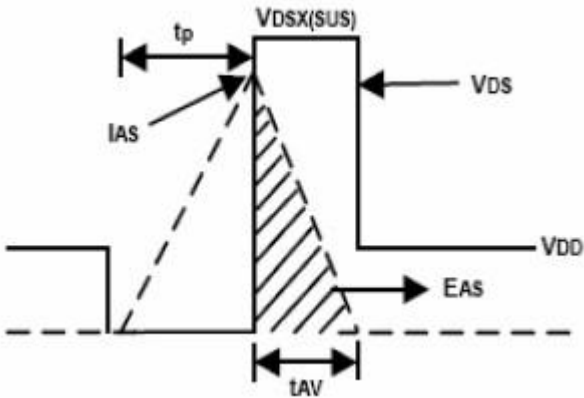
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	75			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current(Tc=25°C)	V <sub>DS</sub> =75V, V <sub>GS</sub> =0V			1	μA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current(Tc=125°C)	V <sub>DS</sub> =75V, V <sub>GS</sub> =0V			10	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2		4	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =40A		7.0	8.5	mΩ
<b>Dynamic Characteristics</b>						
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =15A	20			S
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz		5053		PF
C <sub>oss</sub>	Output Capacitance			442		PF
C <sub>rss</sub>	Reverse Transfer Capacitance			145		PF
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =50V, I <sub>D</sub> =40A, V <sub>GS</sub> =10V		115		nC
Q <sub>gs</sub>	Gate-Source Charge			20		nC
Q <sub>gd</sub>	Gate-Drain Charge			50		nC
<b>Switching Times</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =30V, I <sub>D</sub> =40A, R <sub>L</sub> =15Ω V <sub>GS</sub> =10V, R <sub>G</sub> =2.5Ω		23		nS
t <sub>r</sub>	Turn-on Rise Time			51		nS
t <sub>d(off)</sub>	Turn-Off Delay Time			66		nS
t <sub>f</sub>	Turn-Off Fall Time			23		nS
<b>Source-Drain Diode Characteristics</b>						
I <sub>SD</sub>	Source-drain Current(Body Diode)			86		A
I <sub>SDM</sub>	Pulsed Source-Drain Current(Body Diode)			368		A
V <sub>SD</sub>	Forward On Voltag (Note 1)	T <sub>J</sub> =25°C, I <sub>SD</sub> =40A, V <sub>GS</sub> =0V		0.89	0.99	V
t <sub>rr</sub>	Reverse Recovery Tim (Note 1)	T <sub>J</sub> =25°C, I <sub>F</sub> =75A di/dt=100A/μs		41		nS
Q <sub>rr</sub>	Reverse Recovery Charg (Note 1)			86		nC
t <sub>on</sub>	Forward Turn-on Time	Intrinsic turn-on time is negligible(turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

Notes 1. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 1.5%, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C

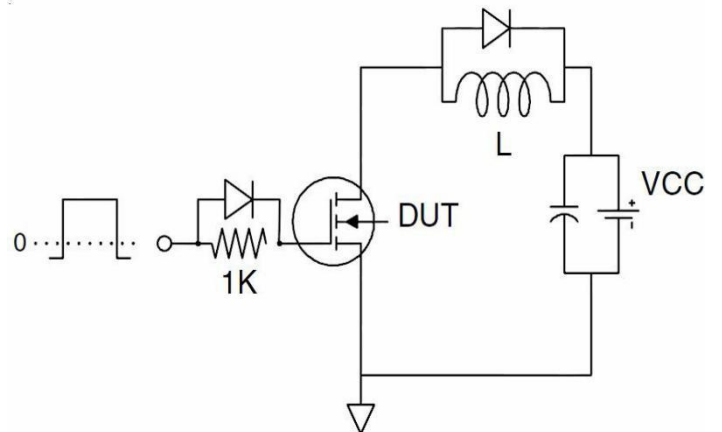
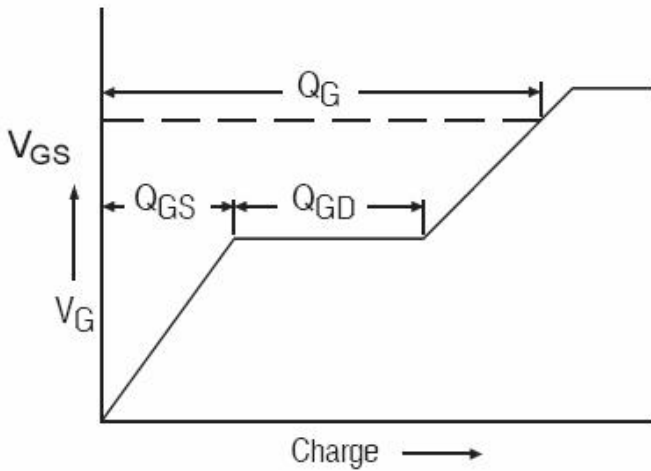


### Test Circuit

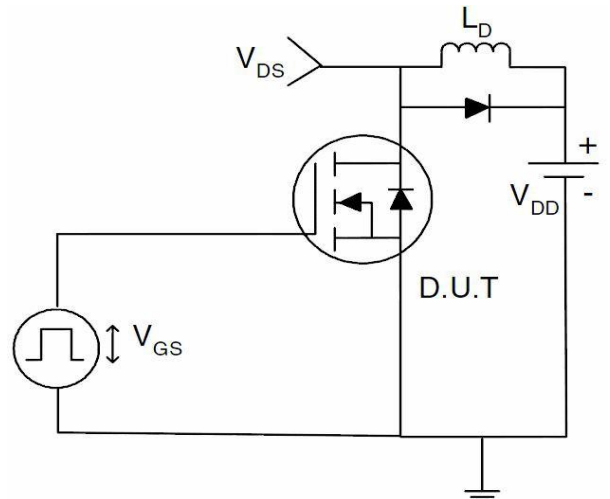
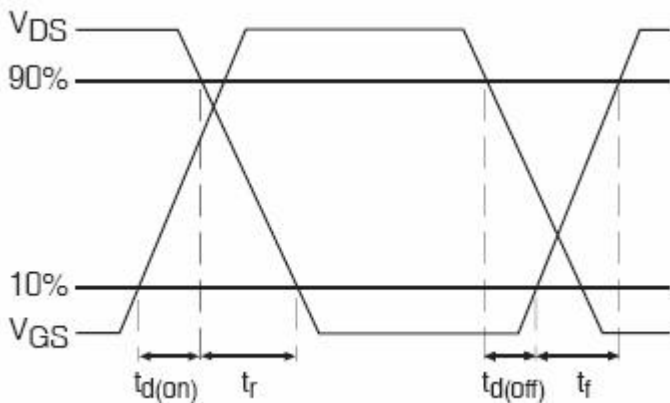
#### 1) EAS Test Circuits



#### 2) Gate Charge Test Circuit:



#### 3) Switch Time Test Circuit:





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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)

Figure1. Output Characteristics

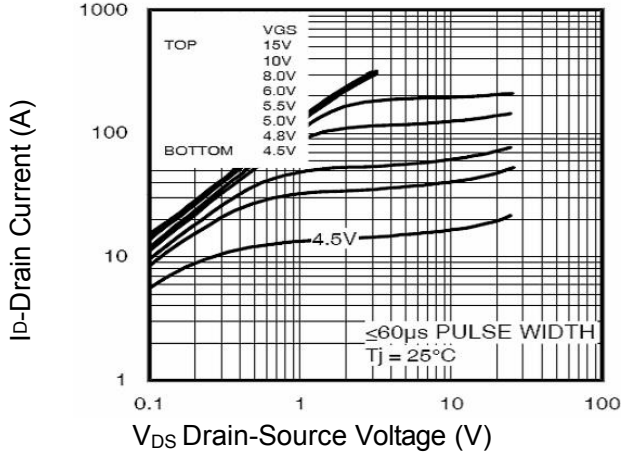


Figure2. Transfer Characteristics

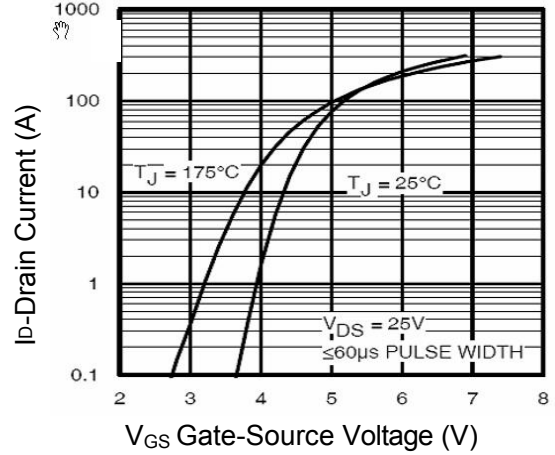


Figure3. BVDSS vs Junction Temperature

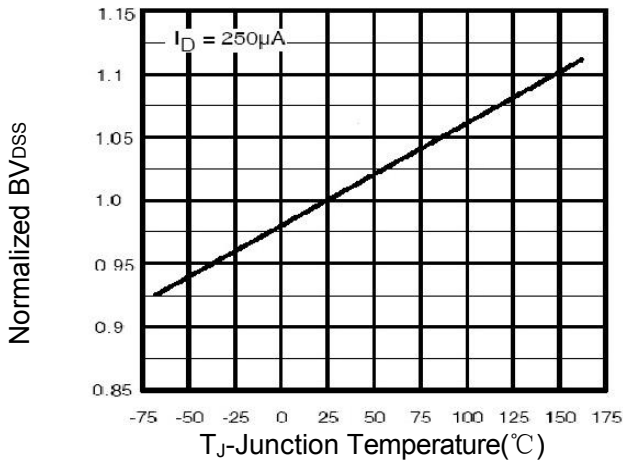


Figure4. ID vs Junction Temperature

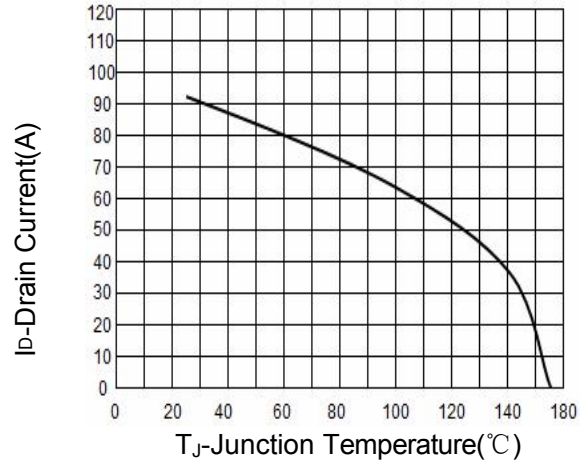


Figure5. VGS(th) vs Junction Temperature

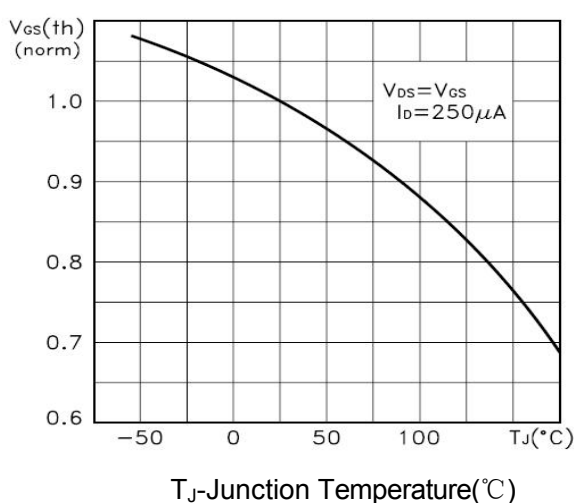
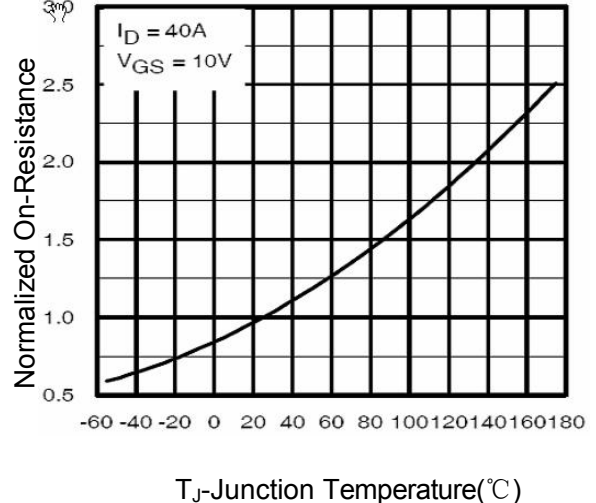


Figure6. Rds(on) Vs Junction Temperature





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Figure7. Gate Charge

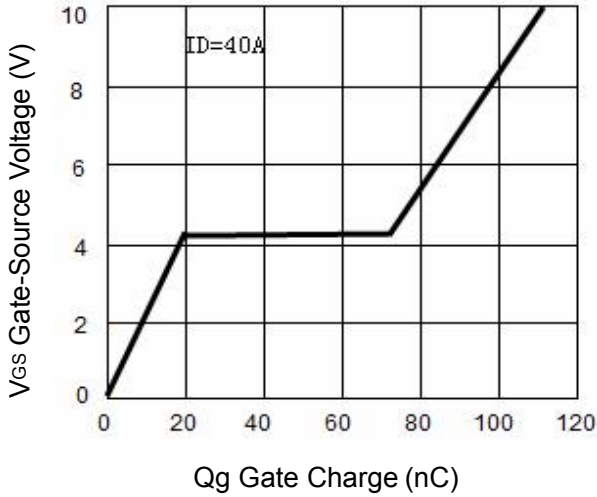


Figure8. Capacitance vs Vds

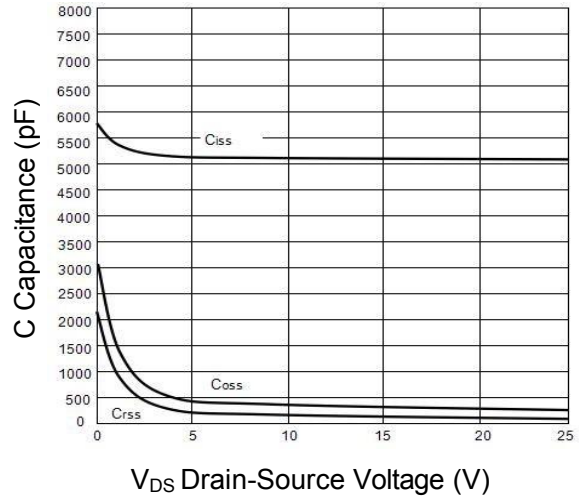


Figure9. Source- Drain Diode Forward

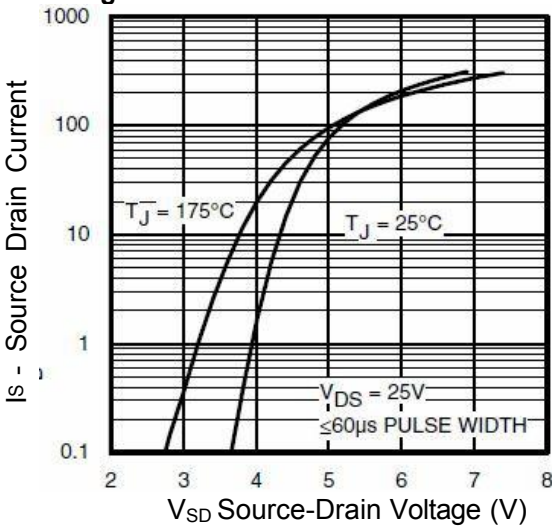


Figure10. Safe Operation Area

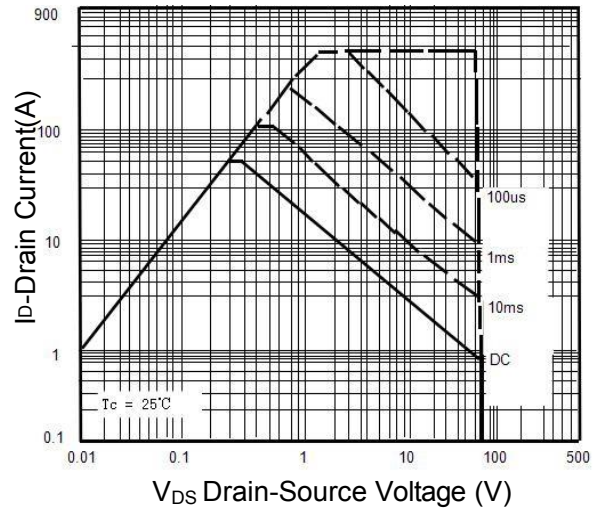
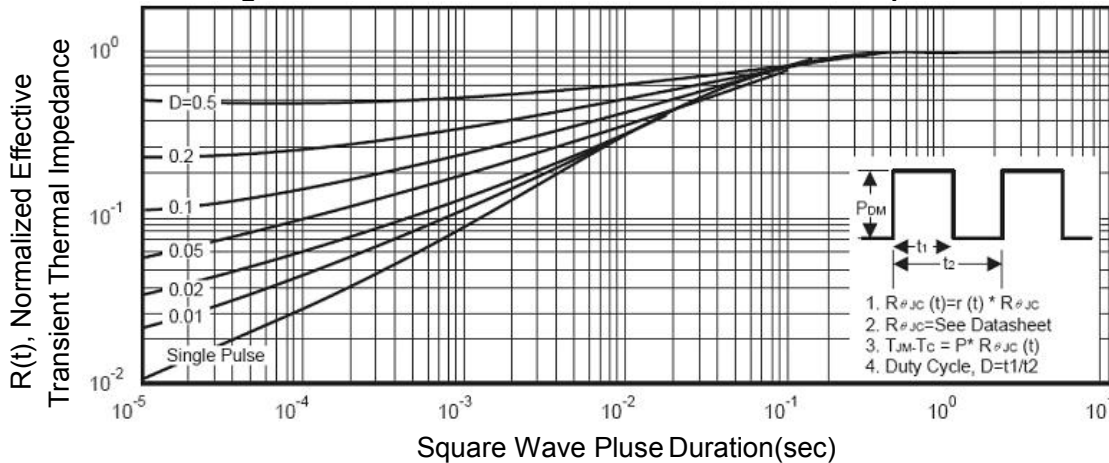
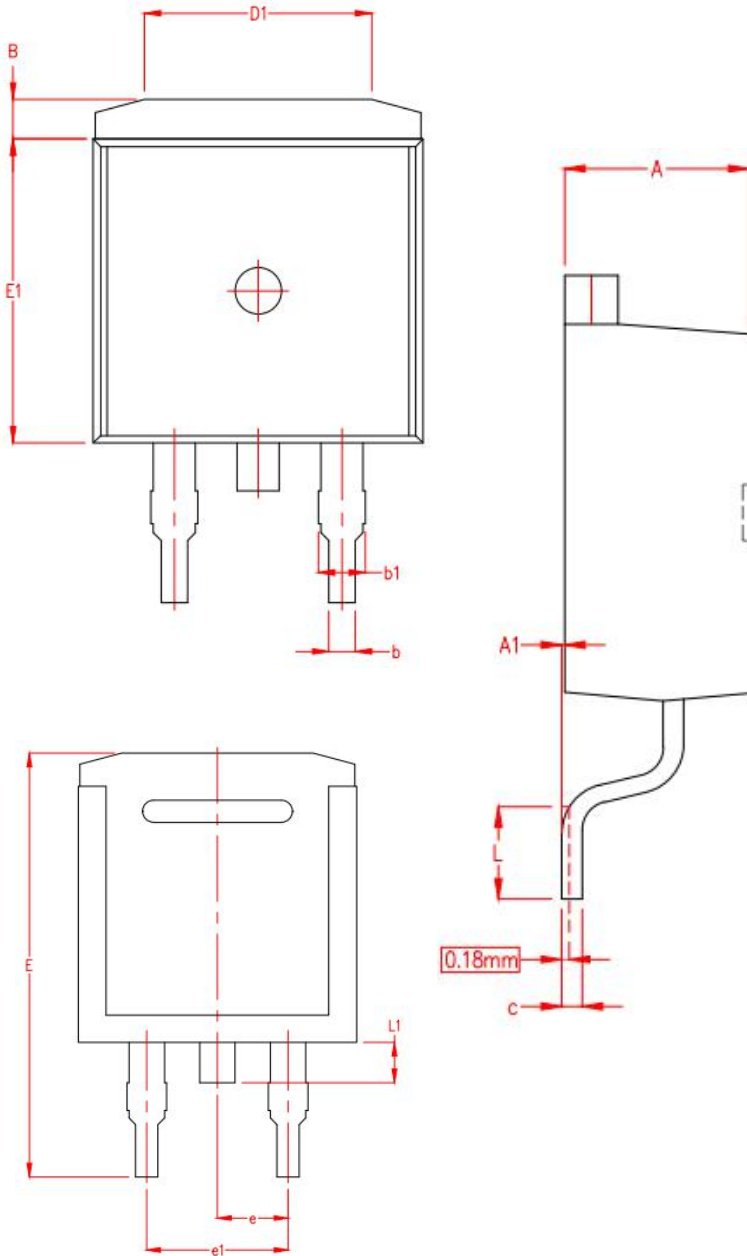


Figure11. Normalized Maximum Transient Thermal Impedance





TO-263 Package Information



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.45	4.50	4.55
A1	0	0.07	0.15
B	1.08	1.20	1.32
b	0.80TYP.		
b1	1.24	1.27	1.30
c	0.48	0.50	0.52
D	9.95	10.00	10.05
D1	6.89REF.		
E	15.09	15.24	15.39
E1	9.15	9.20	9.25
e	2.51	2.54	2.57
e1	5.05	5.08	5.11
L	2.29	2.54	2.79